

# RJK2555DPA-VB Datasheet N-Channel 250 V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	250				
$R_{DS(on)}$ Typ. ( $\Omega$ ) at $V_{GS} = 10 \text{ V}$	0.042				
$R_{DS(on)}$ Typ. ( $\Omega$ ) at $V_{GS} = 7.5 \text{ V}$	0.048				
Q <sub>g</sub> typ. (nC)	20				
I <sub>D</sub> (A)	35				
Configuration	Single				

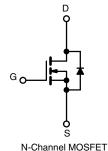
#### **FEATURES**

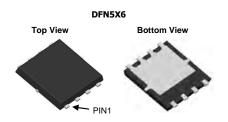
- $\bullet$  ThunderFET® technology optimizes balance of  $R_{DS(on)},\,Q_g,\,Q_{sw}$  and  $Q_{oss}$
- 100 % R<sub>g</sub> and UIS tested

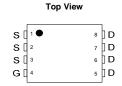


#### **APPLICATIONS**

- Fixed telecom
- DC/DC converter
- Primary and secondary side switch
- Synchronous rectification
- LED lighting
- Power supplies
- · Class D amplifier







PARAMETER Drain-source voltage		SYMBOL	LIMIT	UNIT	
		V <sub>DS</sub>	250	V	
Gate-source voltage		V <sub>GS</sub>	± 20	V	
	T <sub>C</sub> = 25 °C		35		
Continuous dunin suurent (T. 150 °C)	T <sub>C</sub> = 70 °C	1 [	25		
Continuous drain current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	8.6 b, c		
	T <sub>A</sub> = 70 °C	1	6.9 b, c	А	
Pulsed drain current (t = 100 μs)		I <sub>DM</sub>	80		
Continuous source-drain diode current	T <sub>C</sub> = 25 °C		32		
	T <sub>A</sub> = 25 °C	l <sub>s</sub>	6.5 <sup>b, c</sup>		
Single pulse avalanche current		I <sub>AS</sub>	35		
Single pulse avalanche energy	L = 0.1 mH	E <sub>AS</sub>	48	mJ	
	T <sub>C</sub> = 25 °C		109		
Maximum navvar discination	T <sub>C</sub> = 70 °C	1 , [	69.6	W	
Maximum power dissipation	T <sub>A</sub> = 25 °C	P <sub>D</sub>	7.25 <sup>b, c</sup>	VV	
	T <sub>A</sub> = 70 °C	1	5 <sup>b, c</sup>		
Operating junction and storage temperature range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C	
Soldering recommendations (peak temperature) c			260		

THERMAL RESISTANCE RATINGS							
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT		
Maximum junction-to-ambient <sup>b</sup>	t ≤ 10 s	R <sub>thJA</sub>	15	20	°C/W		
Maximum junction-to-case (drain)	Steady state	R <sub>thJC</sub>	0.9	1.2	C/VV		

#### Notes

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. The DFN5x6 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 54 °C/W.
- g.  $T_C = 25$  °C.



PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static	<u> </u>			l .		
Drain-source breakdown voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	250	-	-	V
V <sub>DS</sub> temperature coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = 10 mA	-	173	-	\//0.6
V <sub>GS(th)</sub> temperature coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA	ı	-7.1	ï	mV/°C
Gate-source threshold voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2.0		4.0	
Gate-source leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	100	nA
Zava mata walta wa aluain a wanant		V <sub>DS</sub> = 250 V, V <sub>GS</sub> = 0 V	-	-	1	
Zero gate voltage drain current	I <sub>DSS</sub>	V <sub>DS</sub> = 250 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 70 °C	-	-	15	μA
On-state drain current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 10 \text{ V}, V_{GS} = 10 \text{ V}$	35	-	-	Α
Daily and a second state of the second	Б	V <sub>GS</sub> =10 V, I <sub>D</sub> = 10 A	-	0.042	ï	Ω
Drain-source on-state resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 7.5 \text{ V}, I_D = 10 \text{ A}$	'n	0.048	1	
Forward transconductance <sup>a</sup>	9 <sub>fs</sub>	$V_{DS} = 15 \text{ V}, I_D = 10 \text{ A}$	-	27	-	S
Dynamic <sup>b</sup>						
Input capacitance	C <sub>iss</sub>		-	1180	-	
Output capacitance	C <sub>oss</sub>	$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	142	-	pF
Reverse transfer capacitance	C <sub>rss</sub>		-	11	-	
Total gate charge	0	V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 10 A	-	25	38	nC
	$Q_g$		-	20	30	
Gate-source charge	Q <sub>qs</sub>	$V_{DS} = 100 \text{ V}, V_{GS} = 7.5 \text{ V}, I_D = 10 \text{ A}$	-	6.4	-	
Gate-drain charge	Q <sub>qd</sub>		ı	6.8	ï	
Output charge	Q <sub>oss</sub>	$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}$	-	52	-	
Gate resistance	$R_g$	f = 1 MHz	0.6	2.1	4	Ω
Turn-on delay time	t <sub>d(on)</sub>		ı	9	18	
Rise time	t <sub>r</sub>	$V_{DD} = 100 \text{ V}, R_L = 10 \Omega, I_D \cong 10 \text{ A},$	-	20	40	1
Turn-off delay time	t <sub>d(off)</sub>	$V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$	ı	20	40	
Fall time	t <sub>f</sub>		-	24	48	
Turn-on delay time	t <sub>d(on)</sub>		-	11	22	ns
Rise time	t <sub>r</sub>	$V_{DD} = 100 \text{ V}, R_L = 10 \Omega, I_D \cong 10 \text{ A},$	ı	27	54	
Turn-off delay time	t <sub>d(off)</sub>	$V_{GEN} = 7.5 \text{ V}, R_g = 1 \Omega$	ı	18	36	
Fall time	t <sub>f</sub>		-	24	48	1
<b>Drain-Source Body Diode Characterist</b>	ics					
Continuous source-drain diode current	I <sub>S</sub>	T <sub>C</sub> = 25 °C	-	-	35.4	_
Pulse diode forward current	I <sub>SM</sub>		-	-	80	A
Body diode voltage	V <sub>SD</sub>	I <sub>S</sub> = 5 A, V <sub>GS</sub> = 0 V	-	0.77	1.1	V
Body diode reverse recovery time	t <sub>rr</sub>		-	100	200	ns
Body diode reverse recovery charge	Q <sub>rr</sub>		-	400	800	nC
Reverse recovery fall time	ta	$I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 \text{ °C}$	-	80	-	
Reverse recovery rise time	t <sub>b</sub>		-	20	_	ns

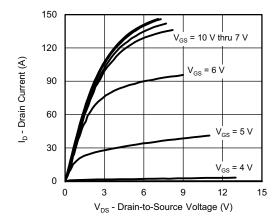
#### Notes

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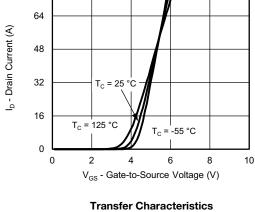
- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

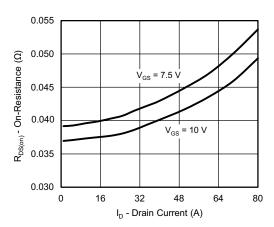




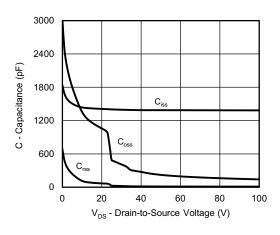
**Output Characteristics** 



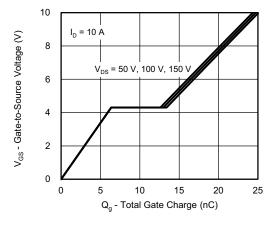
80



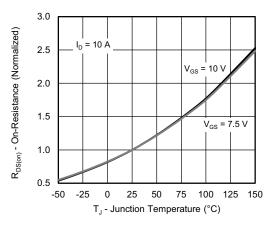
On-Resistance vs. Drain Current and Gate Voltage



Capacitance

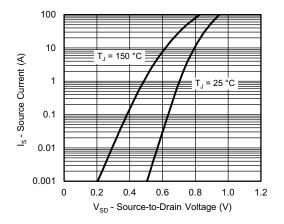


**Gate Charge** 

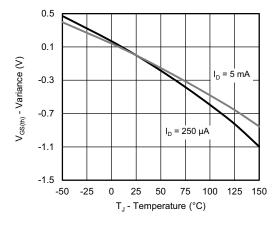


On-Resistance vs. Junction Temperature

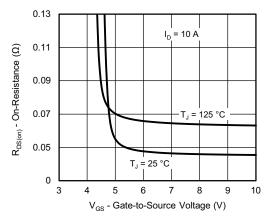




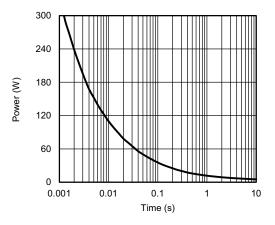
Source-Drain Diode Forward Voltage



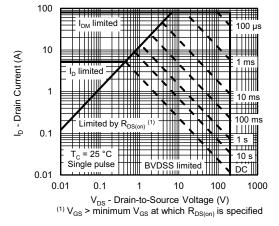
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage

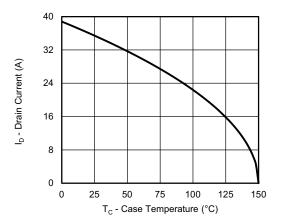


Single Pulse Power, Junction-to-Ambient

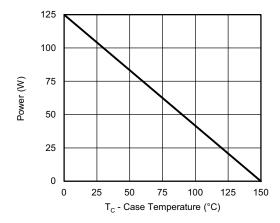


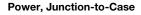
Safe Operating Area, Junction-to-Ambient

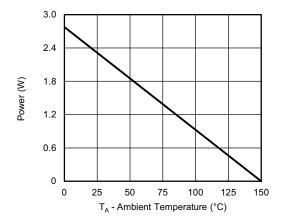




### Current Derating a





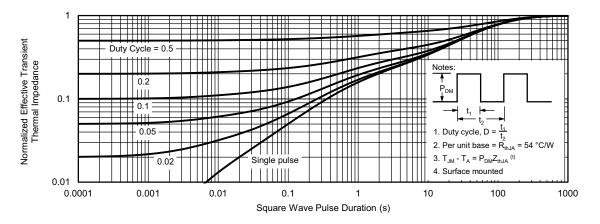


Power, Junction-to-Ambient

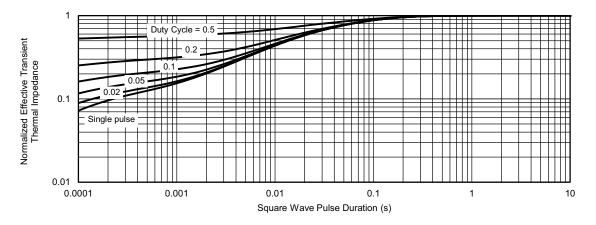
#### Note

a. The power dissipation P<sub>D</sub> is based on T<sub>J</sub> max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





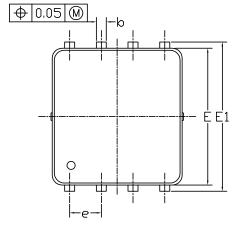
Normalized Thermal Transient Impedance, Junction-to-Ambient

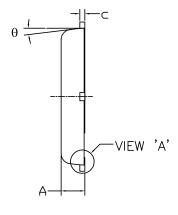


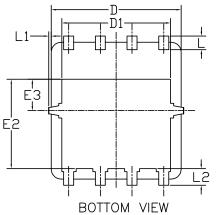
Normalized Thermal Transient Impedance, Junction-to-Case

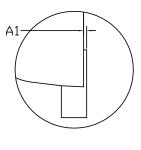


## DFN5x6\_8L\_EP1\_P PACKAGE OUTLIN

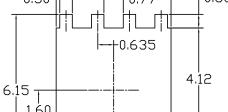








VIEW 'A' (SCALE 5:1)



RECOMMENDED LAND PATTERN

0.50-		—4.	60 <u> </u>	7		-0.55
15 <del> </del> 1.60	J ¦ L	J¦L 	_  -0.63 	35	4.	12
0.50-	+	+	+  1.6	+ <u>+</u>	0.6	55

SYMBOLS	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES			
31 MBOLS	MIN	NOM	MAX	MIN	NOM	MAX	
A	0.85	0. 95	1.00	0.033	0.037	0.039	
A1	0.00		0.05	0.000		0.002	
b	0.30	0.40	0.50	0.012	0.016	0.020	
С	0.15	0.20	0. 25	0.006	0.008	0.010	
D	5. 10	5. 20	5. 30	0. 201	0. 205	0. 209	
D1	4. 25	4. 35	4. 45	0. 167	0. 171	0. 175	
Е	5. 45	5. 55	5. 65	0. 215	0.219	0. 222	
E1	5. 95	6.05	6. 15	0. 234	0. 238	0. 242	
E2	3. 525	3. 625	3. 725	0. 139	0. 143	0. 147	
E3	1. 175	1.275	1. 375	0.046	0.050	0.054	
e	1. 27 BSC			0.050 BSC			
L	0.45	0. 55	0.65	0.018	0.022	0.026	
L1	0		0. 15	0		0.006	
L2	0.68 REF			0. 027 REF			
θ	0°		10°	0°		10°	

#### **NOTE**

UNIT: mm

- 1. PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS. MOLD FLASH AT THE NON-LEAD SIDES SHOULD BE LESS THAN 6 MILS EACH.
- 2. CONTROLLING DIMENSION IS MILLIMETER. CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.



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